Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/618,402	TEE ET AL.
Examiner	Art Unit
Shih-wen Hsieh	2861

SEARCHED					
Class	Subclass	Date	Examiner		
updated	updated	3/23/2005	SWH		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
347	29,32	3/23/2005	SWH	

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